

# ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3

# EcoSPARK<sup>TM</sup> 300mJ, 360V, N-Channel Ignition IGBT

# **General Description**

The ISL9V3036D3S, ISL9V3036S3S, and ISL9V3036P3 are the next generation IGBTs that offer outstanding SCIS capability in the space saving D-Pak (TO-252), as well as the industry standard D²-Pak (TO-263) and TO-220 plastic packages. These devices are intended for use in automotive ignition circuits, specifically as a coil drivers. Internal diodes provide voltage clamping without the need for external components.

**EcoSPARK™** devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

# Applications

- · Automotive Ignition Coil Driver Circuits
- Coil- On Plug Applications

### **Features**

- Industry Standard D<sup>2</sup>-Pak package
- SCIS Energy = 300mJ at T<sub>J</sub> = 25°C
- · Logic Level Gate Drive

Formerly Developmental Type 49442

# Package Symbol JEDEC TO-252AA JEDEC TO-263AB JEDEC TO-220AB E C G GATE COLLECTOR (FLANGE) (FLANGE)

# **Device Maximum Ratings** $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Ratings	Units
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage (I <sub>C</sub> = 1 mA)	360	V
BV <sub>ECS</sub>	Emitter to Collector Voltage - Reverse Battery Condition (I <sub>C</sub> = 10 mA)	24	V
E <sub>SCIS25</sub>	$T_J = 25$ °C, $I_{SCIS} = 14.2$ A, $L = 3.0$ mHy	300	mJ
E <sub>SCIS150</sub>	$T_J = 150$ °C, $I_{SCIS} = 10.6$ A, $L = 3.0$ mHy	170	mJ
I <sub>C25</sub>	Collector Current Continuous, At T <sub>C</sub> = 25°C, See Fig 9	21	Α
I <sub>C110</sub>	Collector Current Continuous, At T <sub>C</sub> = 110°C, See Fig 9	17	Α
V <sub>GEM</sub>	Gate to Emitter Voltage Continuous	±10	V
P <sub>D</sub>	Power Dissipation Total T <sub>C</sub> = 25°C	150	W
	Power Dissipation Derating T <sub>C</sub> > 25°C	1.0	W/°C
T <sub>J</sub>	T <sub>J</sub> Operating Junction Temperature Range		°C
T <sub>STG</sub>	Storage Junction Temperature Range		°C
T <sub>L</sub>	Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)	300	°C
T <sub>pkg</sub>	Max Lead Temp for Soldering (Package Body for 10s)	260	°C
ESD	Electrostatic Discharge Voltage at 100pF, 1500Ω	4	kV

achay	e Marking and	Cruering III	ioi illation						
Device Marking Device Package		Reel Size		Tape	Width		Quantity		
		T TO-252AA	330mm		16	6mm		2500	
V30365	S ISL9V3036S3S	T TO-263AB	330mm		24	1mm		800	
V3036P ISL9V3036P3 TO-220AA		TO-220AA	Tube		1	N/A		50	
V3036E	ISL9V3036D3S	S TO-252AA	Tube		N/A			75	
V3036S ISL9V3036S3S TO-263AB		Tube		N/A			50		
Electric	al Characterist	<b>iCS</b> T <sub>J</sub> = 25°C ur	nless otherwise n	oted					
Symbol	Param	neter	Test Conditions		Min	Тур	Max	Units	
Off State	Characteristics								
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage		$I_C = 2mA$ , $V_{GE} = 0$ , $R_G = 1K\Omega$ , See Fig. 15 $T_{.1} = -40$ to 150°C		330	360	390	V	
D\/	Callactor to Emitter B	0 11 1 15 11 11 11 11 11			250	200	440	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
BV <sub>CES</sub>	Collector to Emitter B	reakdown voitage	$I_C = 10 \text{mA}, V_{GE} = 0,$ $R_G = 0, \text{ See Fig. 15}$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		350	380	410	V	
BV <sub>ECS</sub>	Emitter to Collector B	reakdown Voltage	•		30	-	-	V	
BV <sub>GES</sub>	Gate to Emitter Breal	kdown Voltage	$I_{GES} = \pm 2mA$		±12	±14	-	V	
I <sub>CER</sub>	Collector to Emitter L	eakage Current	$V_{CER} = 250V,$	T <sub>C</sub> = 25°C	-	-	25	μA	
		-	$R_G = 1KΩ$ , See Fig. 11	T <sub>C</sub> = 150°C	-	-	1	mA	
I <sub>ECS</sub>	Emitter to Collector Leakage Current		$V_{EC} = 24V$ , See	$T_C = 25^{\circ}C$	-	-	1	mA	
			Fig. 11	$T_C = 150$ °C	-	-	40	mA	
R <sub>1</sub>	Series Gate Resistance				-	70	-	Ω	
$R_2$	Gate to Emitter Resistance				10K	-	26K	Ω	
On State	Characteristics								
V <sub>CE(SAT)</sub>	Collector to Emitter S	aturation Voltage	$I_C = 6A,$ $V_{GE} = 4V$	$T_C = 25$ °C, See Fig. 3	-	1.25	1.60	V	
V <sub>CE(SAT)</sub>	Collector to Emitter S	aturation Voltage	$I_{C} = 10A,$ $V_{GE} = 4.5V$	$T_C = 150$ °C, See Fig. 4	-	1.58	1.80	V	
V <sub>CE(SAT)</sub>	Collector to Emitter S	aturation Voltage	$I_C = 15A,$ $V_{GE} = 4.5V$	T <sub>C</sub> = 150°C	-	1.90	2.20	V	
Dynamic	Characteristics								
Q <sub>G(ON)</sub>	Gate Charge		$I_C = 10A$ , $V_{CE} = V_{GE} = 5V$ , See	= 12V, Fig. 14	-	17	-	nC	
V <sub>GE(TH)</sub>	Gate to Emitter Three	shold Voltage	$I_C = 1.0 \text{mA},$	$T_C = 25^{\circ}C$	1.3	-	2.2	V	
•			V <sub>CE</sub> = V <sub>GE,</sub> See Fig. 10	T <sub>C</sub> = 150°C	0.75	-	1.8	V	
$V_{GEP}$	Gate to Emitter Plate	au Voltage	I <sub>C</sub> = 10A,	V <sub>CE</sub> = 12V	-	3.0	-	V	
Switching	Characteristics								
t <sub>d(ON)R</sub>	Current Turn-On Dela	ay Time-Resistive	V <sub>CE</sub> = 14V, R <sub>L</sub> :	= 1Ω,	-	0.7	4	μs	
t <sub>rR</sub>	Current Rise Time-R		$V_{GE} = 5V, R_G = 1K\Omega$ $T_J = 25^{\circ}C, See Fig. 12$		-	2.1	7	μs	
t <sub>d(OFF)L</sub>	Current Turn-Off Dela	ay Time-Inductive	$V_{CE} = 300V, R_L = 500\mu H,$		-	4.8	15	μs	
	Current Fall Time-Inc	luctive	$V_{GE} = 5V, R_G = 1K\Omega$ $T_J = 25^{\circ}C, See Fig. 12$		-	2.8	15	μs	
t <sub>fL</sub>			1j = 25 C, See	1 1g: 12					

TO-252, TO-263, TO-220

 $\mathsf{R}_{\theta\mathsf{JC}}$ 

Thermal Resistance Junction-Case

°C/W

# **Typical Performance Curves**

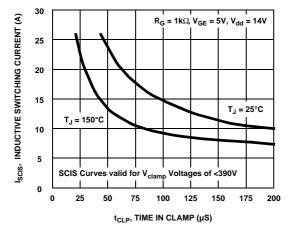


Figure 1. Self Clamped Inductive Switching Current vs Time in Clamp

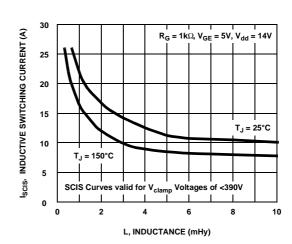


Figure 2. Self Clamped Inductive Switching Current vs Inductance

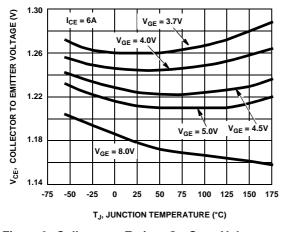


Figure 3. Collector to Emitter On-State Voltage vs Junction Temperature

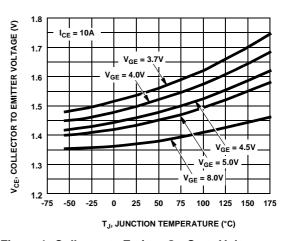


Figure 4. Collector to Emitter On-State Voltage vs Junction Temperature

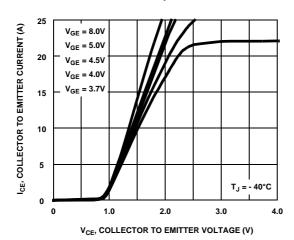


Figure 5. Collector to Emitter On-State Voltage vs Collector Current

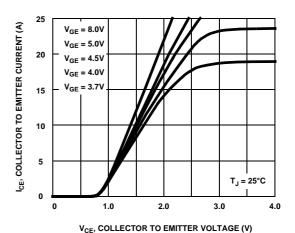
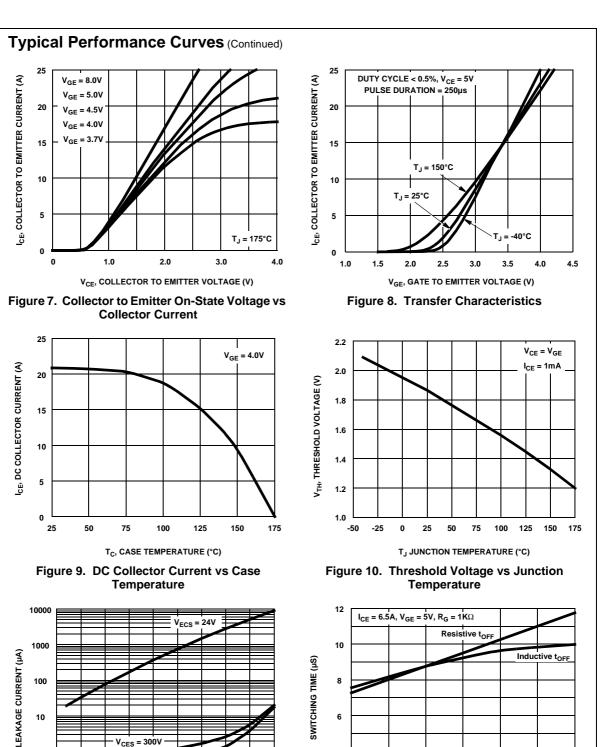


Figure 6. Collector to Emitter On-State Voltage vs Collector Current



4

2

25

50

75

100

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 12. Switching Time vs Junction

**Temperature** 

V<sub>CES</sub> = 250V

125 150

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 11. Leakage Current vs Junction

**Temperature** 

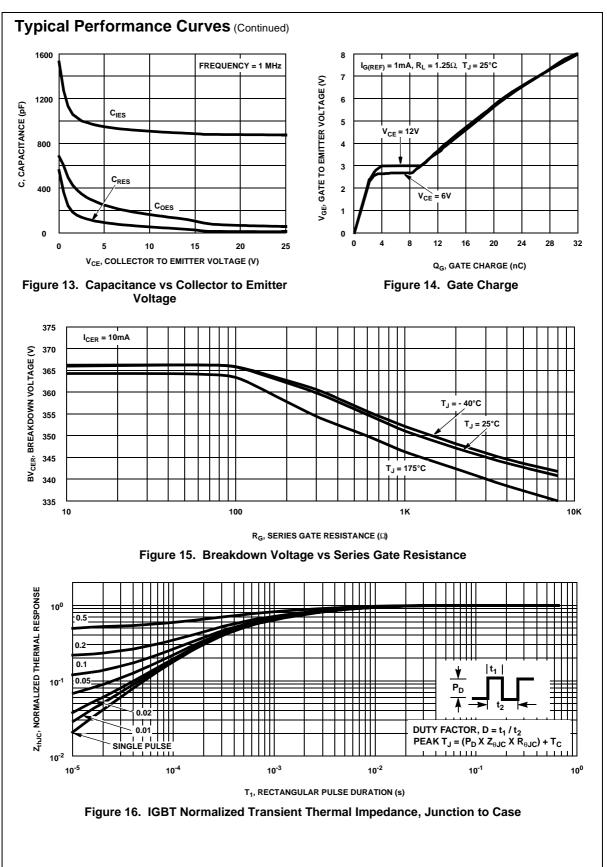
0.1

125

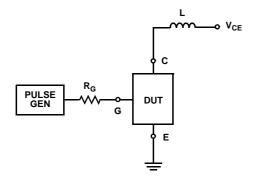
Resistive toN

150

175



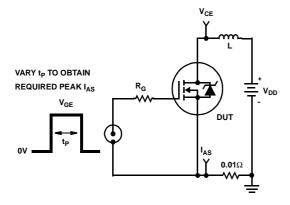
# **Test Circuit and Waveforms**



 $R_{G} = 1K\Omega$  DUT  $V_{CE}$ 

Figure 17. Inductive Switching Test Circuit

Figure 18.  $t_{ON}$  and  $t_{OFF}$  Switching Test Circuit



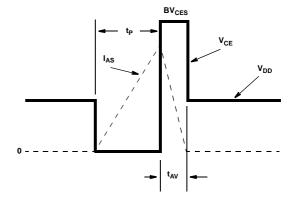


Figure 19. Unclamped Energy Test Circuit

Figure 20. Unclamped Energy Waveforms

### SPICE Thermal Model JUNCTION REV 24 April 2002 ISL9V3036D3S/ ISL9V3036S3S / ISL9V3036P3 CTHERM1 th 6 2.1e -3 CTHERM2 6 5 1.4e -1 RTHERM1 CTHERM1 CTHERM3 5 4 7.3e -3 CTHERM4 4 3 2.1e -1 CTHERM5 3 2 1.1e -1 CTHERM6 2 tl 6.2e +6 6 RTHERM1 th 6 1.2e -1 RTHERM2 6 5 1.9e -1 RTHERM2 CTHERM2 RTHERM3 5 4 2.2e -1 RTHERM4 4 3 6.0e -2 RTHERM5 3 2 5.8e -2 RTHERM6 2 tl 1.6e -3 5 SABER Thermal Model CTHERM3 RTHERM3 SABER thermal model ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3 template thermal\_model th tl thermal\_c th, tl 4 ctherm.ctherm1 th 6 = 2.1e - 3ctherm.ctherm2 6.5 = 1.4e - 1ctherm.ctherm3 5 4 = 7.3e -3RTHERM4 CTHERM4 ctherm.ctherm4 4 3 = 2.2e -1 ctherm.ctherm5 3 2 =1.1e -1 ctherm.ctherm6 2 tl = 6.2e +6 3 rtherm.rtherm1 th 6 = 1.2e -1rtherm.rtherm2 6 5 = 1.9e - 1rtherm.rtherm354 = 2.2e-1RTHERM5 CTHERM5 rtherm.rtherm4 4 3 = 6.0e - 2rtherm.rtherm5 3 2 = 5.8e - 2rtherm.rtherm6 2 tl = 1.6e - 32 CTHERM6 RTHFRM6 CASE

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